Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/697,941	TAKAYAMA ET AL.	
Examiner	Art Unit	
Joseph Nguyen	2815	

SEARCHED				
Class	Subclass	Date	Examiner	
257	59,40	10/31/2005	JN	
257	72	10/31/2005	JN	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	J				

SEARCH (INCLUDING SEAF	NOTES RCH STRATE(	GY)
	DATE	EXMR
search history printout	10/31/200	95 JN